## Notice of References Cited Application/Control No. 10/589,822 Examiner TUNG X. LE Applicant(s)/Patent Under Reexamination WATANABE ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0183473	09-2004	Kamoi et al.	315/291
*	В	US-2003/0062848	04-2003	Prasad, Himamshu V.	315/224
*	C	US-7,064,495	06-2006	Lurkens et al.	315/224
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	I	US-			
	J	US-			
	K	US-			
	L_	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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